

<b>Notice of References Cited</b>	Application/Control No. 10/715,931	Applicant(s)/Patent Under Reexamination JENG, ERIK S.	
	Examiner Jesse A. Fenty	Art Unit 2815	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,613,623 B1	09-2003	Tsai et al.	438/197
	B	US-5,734,185	03-1998	Iguchi et al.	257/336
	C	US-6,482,691 B2	11-2002	Wu et al.	438/217
	D	US-6,180,978 B1	01-2001	Chatterjee et al.	257/327
	E	US-2003/0094662 A1	05-2003	Bae et al.	257/408
	F	US-2002/0142523 A1	10-2002	Ryu et al.	438/149
	G	US-2002/0132431 A1	09-2002	Fung et al.	438/300
	H	US-6,399,469 B1	06-2002	Yu, Bin	438/595
	I	US-2002/0089021 A1	07-2002	Ko, Joe	257/408
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.